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# Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China







## **APDS-9200**

## Digital UV and Ambient Light Sensor



## **Data Sheet**

### **Description**

The Broadcom APDS-9200 device provides ultra-violet (UV-A and UV-B) sensing and ambient light sensing in a specially designed matrix arrangement for optimization. This allows the device to have optimal angular response for ultra-violet and ambient light sensing. The APDS-9200 converts UV light into digital data and display as UV index (1... >11) with higher values representing higher UV exposures.

The ultra-violet sensing feature is useful in consumer applications for monitoring of UV-A and UV-B radiation as UV radiation is part of the electromagnetic spectrum that reaches the earth from the sun. APDS-9200 is able to measure UV wavelength which has been classified into UV-A (320 nm – 400 nm) and UV-B (290 nm – 320 nm). The ambient light sensing is targeted for display management with the purpose of extending battery life and offers optimum viewing in diverse lightning conditions.

APDS-9200 supports the I<sup>2</sup>C interface and has a programmable interrupt function that frees up micro-controller resources using upper and lower thresholds events.

## **Ordering Information**

Part Number	Packaging	Quantity	
APDS-9200	Tape and Reel	2500 per reel	

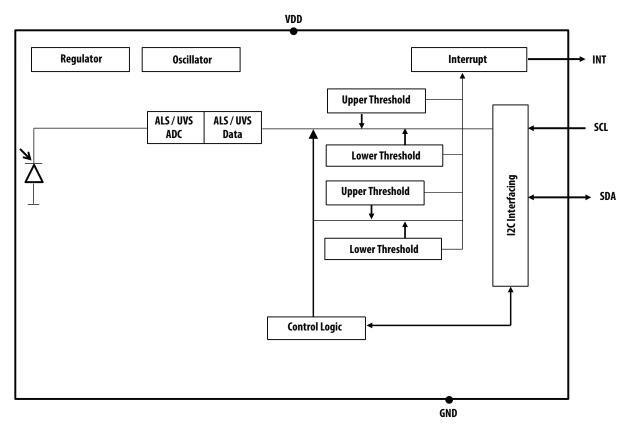
#### **Features**

- Ultra-Violet (UV-A and UV-B) and ambient light sensing
  - Digital UV Index register (1 ... > 11)
  - Linear output
  - Excellent temperature compensation
- Ambient Light Sensing (ALS)
  - Utilizes coating technology to emulate human eye spectral response (V-Lamda characteristics)
  - High sensitivity in low lux condition Ideally suited for operation behind dark glass
  - Low lux performance at 0.008 lux
  - Up to 20-bit resolution
- I<sup>2</sup>C Interface Compatible
  - Up to 400 kHz (I<sup>2</sup>C Fast-Mode)
  - Dedicated interrupt pin
- Small package: L 2.0 mm × W 2.0 mm × H 0.65 mm

### **Applications**

- Ultra-violet and Ambient Light Sensing
- Mobile devices cell phones, tablets, outdoor navigation display
- Wearable devices smart watch, sport watch

Figure 1 Functional Block Diagram



## **Detailed Description**

The APDS-9200 device contains multiple photodiodes for UV and Ambient Light Sensing as well as temperature compensation that are designed in a matrix placement to achieve optimum angular response at the fall of incident light angle. The photodiode currents are converted to digital count by ADCs. The ADC resolution is selected from 13 bits to 20 bits and the conversion time is inversely proportional to the ADC resolution. The device is connected by an I<sup>2</sup>C interface to a microcontroller through a set of registers. APDS-9200 has a programmable interrupt with hysteresis to respond to events which will reduce the microcontroller tasks with upper and lower thresholds. The device includes a circuit for an internal oscillator, a current source, voltage reference, and internal nonvolatile memory (NVM) to store trimming information.

The UV light sensor has to be operated independently from Ambient Light Sensor. To enable the reading of UV sensor, UVS\_MODE and LS\_EN bit has to be correctly set in the MAIN\_CTRL register. Setting the UVS\_MODE bit will stop a running ALS measurement and start a new UV sensor reading.

Table 1 I/O Pins Configuration

Pin	Name	Туре	Description
1	SCL	I	I <sup>2</sup> C serial clock input terminal — clock signal for I2C serial data
2	SDA	I/O	I <sup>2</sup> C serial data I/O terminal – serial data I/O for I2C
3	VDD	Supply	Power Supply Voltage
4	INT	0	Interrupt – Open drain
5	NC		No Connect
6	GND	Ground	Power supply ground. All voltages are referenced to GND

Table 2 Absolute Maximum Ratings over Operating Free-Air Temperature Range (unless Otherwise Noted)

Parameter	Symbol	Min.	Max.	Units	Conditions
Power supply voltage	$V_{DD}$		4.0	V	All voltages are with respect to GND.
Max voltage on SCL, SDA, INT pads	V <sub>I2C</sub>	0.5	4.0	V	
Storage temperature	T <sub>stg</sub>	-40	95	℃	

#### **Table 3 Recommended Operating Conditions**

Parameter	Symbol	Min.	Тур.	Max.	Units
Operating ambient temperature	$T_A$	-40		85	°C
Supply voltage	$V_{DD}$	1.7		3.6	٧
Supply Voltage accuracy, VDD total error including transients		-3		3	%

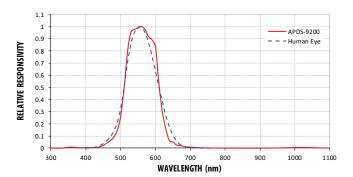
### Table 4 Electrical Parameters, T<sub>A</sub>=25°C (unless Otherwise Noted)

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Units
ALS Active mode current	I <sub>ALS</sub>	V <sub>DD</sub> = 2.8V, Gain Mode 3		110		μΑ
UV Active mode current	I <sub>UV</sub>	V <sub>DD</sub> = 2.8V		100		μΑ
Standby current	I <sub>STBY</sub>	In Standby Mode. No active I <sup>2</sup> C communication		1	2	μΑ
SCL, SDA input high voltage	V <sub>IH</sub>		1.5		$V_{DD}$	V
SCL, SDA input low voltage	V <sub>IL</sub>		0		0.4	V
VOL INT, SDA output low voltage			0		0.4	V
ILEAK leakage current, SDA, SCL, INT pins	ILEAK		-5		5	μΑ

#### **Table 5 ALS/UV Characteristics**

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Units
Dark count		Lux=0, 18 bit range		0		counts
Min integration time	T <sub>intmin1</sub>			3.125		ms
	Ti <sub>ntmin2</sub>	With 50/60Hz rejection		50		ms
Max integration time	T <sub>intmax</sub>	With 50/60Hz rejection		400		ms
ALS output resolution	RES <sub>ALS</sub>	Programmable	13	18	20	bits
UV output resolution	RES <sub>UV</sub>	Programmable	13	18	20	bits
ADC count value		Intensity = 121 $\mu$ W/cm <sup>2</sup> with 310 nm light source, GAIN = 18×, resolution = 20 bits, $V_{DD}$ = 2.8V		1700		counts
ALS/UV repeat rate		Programmable	25		2000	ms

**Figure 2 ALS Spectral Response** 



**Figure 3 UV Spectral Response** 

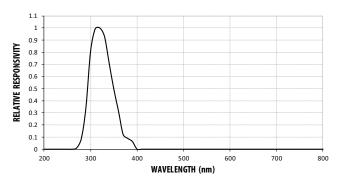


Figure 4 ALS Sensor LUX vs. Meter LUX using White Light

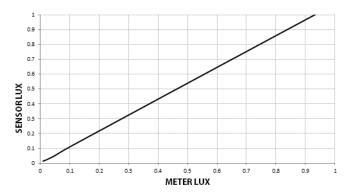


Figure 5 ALS Sensor LUX vs. Meter LUX using White Light

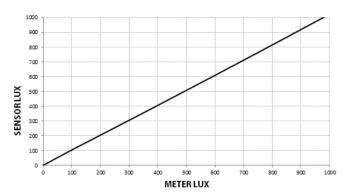


Figure 6 ALS Sensor LUX vs. Meter LUX using Incandescent Light

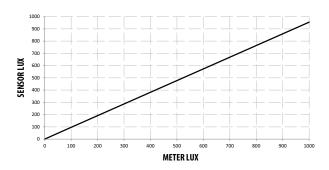


Figure 7 UV Sensor Count vs. UV Meter Index (310 nm UV Source)

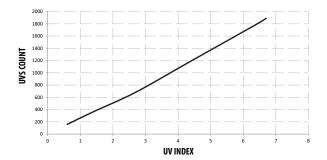


Figure 8 Normalized Standby IDD vs. VDD

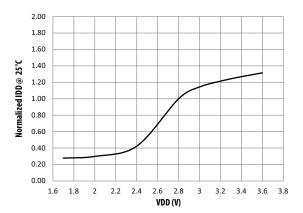


Figure 9 Normalized Standby IDD vs. Temperature

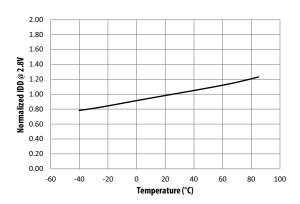


Figure 10 Normalized ALS Data Count @ 1000Lux White LED vs. VDD

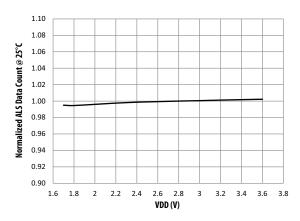


Figure 11 Normalized UVS Data Count @ 121 μW/cm<sup>2</sup> (310 nm) vs. VDD

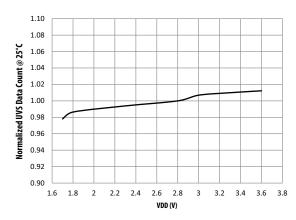


Figure 12 Normalized ALS Data Count @ 2.8V vs. Temperature

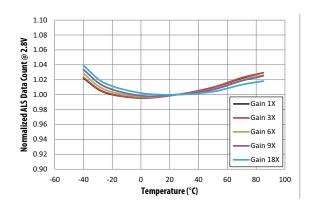


Figure 13 Normalized UVS Data Count @ 121  $\mu$ W/cm<sup>2</sup> (310nm) VDD = 2.8V vs. Temperature

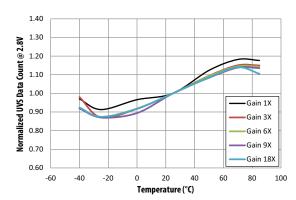


Figure 14 Normalized ALS Responsitivity vs. Angular Displacement

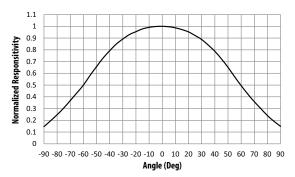
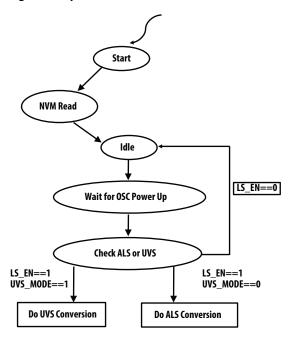


Figure 15 System State Machine



## Start Up after Power-On or Software Reset

The main state machine is set to "Start State" during power-on or software reset. As soon as the reset is released, the internal oscillator is started and the programmed I<sup>2</sup>C address and the trim values are read from the internal trimming data block. The APDS-9200 enters Standby Mode as soon as the idle state is reached.

**NOTE** As long as the I<sup>2</sup>C address has not yet been read, the device will respond with NACK to any I<sup>2</sup>C command and ignore any request to avoid responding to a wrong I<sup>2</sup>C address.

### **Standby Mode**

Standby Mode is the default mode after power-up. In this state, the oscillator, all internal support blocks, and the ADCs are switched off but I<sup>2</sup>C™ communication is fully supported.

### **ALS and UVS Operation**

ALS measurements can be activated by setting the LS\_EN bit to 1 and the UVS Mode bit to 0 in the MAIN CTRL register.

UV measurements can be activated by setting the LS\_EN bit to 1 and the UVS Mode bit to 1 in the MAIN CTRL register.

As soon as ALS or UVS become activated through an I<sup>2</sup>C command, the internal support blocks are powered on. Once the voltages and currents are settled (typically after 5 ms), the state machine checks for trigger events from a measurement scheduler to start the ALS or UVS conversions according to the selected measurement repeat rates.

Once LS\_EN is changed back to 0, a conversion running on the respective channel will be completed and the relevant ADCs and support blocks will move to standby mode.

### **Interrupt Features**

APDS-9200 generates independent Light sensor (ALS/UVS depend on configuration) interrupt signal that can be multiplexed and output to the INT pad. The interrupt conditions are always evaluated after completion of a new conversion on the LS channels.

## **Light Sensor Interrupt**

The LS interrupt is enabled by LS\_INT\_EN = 1. It can function as either threshold triggered (LS\_VAR\_MODE = 0) or variance trigged (LS\_VAR\_MODE = 1). The LS interrupt source generator either uses the ALS\_DATA or the UVS\_DATA registers at input. The LS interrupt source is selected by the LS\_INT\_SEL bits in the INT\_CFG register.

The Light Sensor threshold interrupt is enabled with LS\_INT\_EN = 1 and LS\_VAR\_MODE = 0. It is set when the data of the selected LS\_DATA input register (ALS\_DATA or UVS\_DATA) is above the upper or below the lower threshold for a specified number of consecutive measurements.

The Light Sensor variance interrupt is enabled with LS\_INT\_EN = 1 and LS\_VAR\_MODE = 1. It is set when the absolute value of the difference between the previous and current LS\_DATA data value is above the decoded LS variance threshold for a specified number of consecutive measurements.

### I<sup>2</sup>C Protocol

Interface and control of the APDS-9200 is accomplished through an I<sup>2</sup>C serial compatible interface (standard or fast mode) to a set of registers that provide access to device control functions and output data. The device supports a single slave address of 0x52 hex using 7 bit addressing protocol. (Contact the factory for other addressing options.)

## I<sup>2</sup>C Register Read

The registers can be read individually or in block read mode. When two or more bytes are read in block read mode, reserved register addresses are skipped and the next valid address is referenced. If the last valid address has been reached, but the master continues with the block read, the address counter in the device will not roll over and the device returns 00HEX for every subsequent byte read.

The block read operation is the only way to ensure correct data read out of multi-byte registers and to avoid splitting of results with HIGH and LOW bytes originating from different conversions. During block read access on LS result registers, the result update is blocked.

If a read access is started on an address belonging to a non-readable register, the APDS-9200 will re-turn NACK until the I<sup>2</sup>C operation is ended.

Read operations must follow the timing diagram in Figure 16.

## I<sup>2</sup>C Register Write

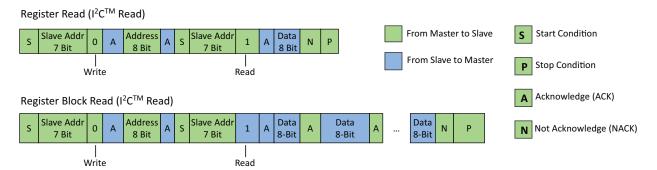
The APDS-9200 registers can be written to individually or in block write mode. When two or more bytes are written in block write mode, reserved registers and read-only registers are skipped. The transmitted data is automatically applied to the next writable register. If a register includes read (R) and read/write (RW) bits, the register is not skipped. Data written to read-only bits are ignored.

If the last valid address of the APDS-9200 address range is reached but the master attempts to continue the block write operation, the address counter of the APDS-9200 will not roll over. The device will return NACK for every following byte sent by the master until the  $I^2C^m$  operation is ended.

If a write access is started on an address belonging to a non-writeable register, the APDS-9200 will return NACK until the  $I^2C^{TM}$  operation is ended.

Write operations must follow the timing diagram in Figure 17.

#### Figure 16 I<sup>2</sup>C Register Read



#### Figure 17 I<sup>2</sup>C Register Write

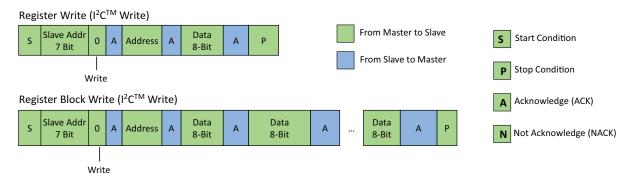
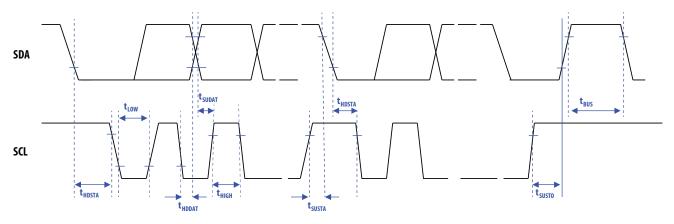


Figure 18 I<sup>2</sup>C Interface – Bus Timing



**Table 6 Bus Timing Characteristics** 

Parameter	Symbol	Standard Mode	Fast Mode	Units
Maximum SCL Clock Frequency	f <sub>SCL</sub>	100	400	KHz
Minimum START Condition Hold Time Relative to SCL Edge	t <sub>DSTA</sub>	4		μs
Minimum SCL Clock Low Width	t <sub>LOW</sub>	4.7		μs
Minimum SCL Clock High Width	t <sub>HIGH</sub>	4		μs
Minimum START Condition Setup Time Relative to SCL Edge	t <sub>SUSTA</sub>	4.7		μs
Minimum Data Hold Time on SDA Relative to SCL Edge	t <sub>HDDAT</sub>	0		μs
Minimum Data Setup Time on SDA Relative to SCL Edge	t <sub>SUDAT</sub>	0.1	0.1	μs
Minimum STOP Condition Setup Time on SCL	t <sub>SUSTO</sub>	4		μs
Minimum Bus Free Time Between Stop Condition and Start Condition	t <sub>BUS</sub>	4.7		μs

## **Register Set**

The APDS-9200 is controlled and monitored by data registers and a command register accessed through the serial interface. These registers provide for a variety of control functions and can be read to determine results of the ADC conversions.

**NOTE** Light Sensor (LS) refers to Ambient Light Sensor (ALS) or UV Sensor (UVS).

**Table 7 Register Set** 

Address	Туре	Name	Description	Reset Value
00HEX	RW	MAIN_CTRL	LS operation mode control, software (SW) reset	00HEX
04HEX	RW LS_MEAS_RATE		LS measurement rate and resolution in active mode	22HEX
05HEX	RW LS_GAIN		LS analog gain range	01HEX
06HEX	_		Part number ID and revision ID	B1HEX
D7HEX	R	MAIN_STATUS	Power-on status, interrupt status, data status	20HEX
ODHEX	R	ALS_DATA_0	ALS ADC measurement data, LSB	00HEX
DEHEX	R	ALS_DATA_1	ALS ADC measurement data	00HEX
OFHEX	R	ALS_DATA_2	ALS ADC measurement data, MSB	00HEX
10HEX	R	UVS_DATA_0	UVS ADC measurement data, LSB	00HEX
11HEX	R	UVS_DATA_1	UVS ADC measurement data	00HEX
12HEX	R	UVS_DATA_2	UVS ADC measurement data, MSB	00HEX
13HEX	R	UVS_COMP_DATA_0	UVS COMP ADC measurement data, LSB	00HEX
14HEX	R	UVS_COMP_DATA_1	UVS COMP ADC measurement data	00HEX
15HEX	R	UVS_COMP_DATA_2	UVS COMP ADC measurement data, MSB	00HEX
16HEX	R	COMP_DATA_0	COMP ADC measurement data, LSB	00HEX
17HEX	R	COMP_DATA_1	COMP ADC measurement data	00HEX
18HEX	R	COMP_DATA_2	COMP ADC measurement data, MSB	00HEX
19HEX	RW	INT_CFG	Interrupt configuration	10HEX
1AHEX	RW	INT_PERSISTENCE	Interrupt persist setting	00HEX
21HEX	RW	LS_THRES_UP_0	LS interrupt upper threshold, LSB	FFHEX
22HEX	RW	LS_THRES_UP_1	LS interrupt upper threshold, intervening bits	FFHEX
23HEX	RW	LS_THRES_UP_2	LS interrupt upper threshold, MSB	0FHEX
24HEX	4HEX RW LS_THRES_LOW_0		LS interrupt lower threshold, LSB	00HEX
25HEX	RW	LS_THRES_LOW_1	LS interrupt lower threshold, intervening bits	00HEX
26HEX	RW	LS_THRES_LOW_2	LS interrupt lower threshold, MSB	00HEX
27HEX	RW	LS_THRES_VAR	LS interrupt variance threshold	00HEX

### MAIN\_CTRL

Default Value: 00HEX

7	6	5	4	3	2	1	0	
0	0	0	SW-Reset	UVS_Mode	0	LS_EN	0	0X00

Field	Bit	Description
SW_Reset	4	1 = Reset will be triggered
UVS_Mode	3	0 = ALS 1 = UVS + compensation channels activated only
LS_EN	1	1 = ALS or UVS active 0 = ALS or UVS standby

### LS\_MEAS\_RATE

Default Value: 22HEX

7	6	5	4	3	2	1	0	
0	LS R	esolution/Bit W	idth	0	LS	Measurement R	Rate	0X0

Field	Bit		Description
LS Resolution / Bit Width	6:4	000:	20 bit – 400 ms
		001:	19 bit – 200 ms
		010:	18 bit – 100 ms (default)
		011:	17 bit – 50 ms
		100:	16 bit – 25 ms
		101:	13 bit – 3.125 ms
		110:	Reserved
		111:	Reserved
LS Measurement Rate	2:0	000:	25 ms
		001:	50 ms
		010:	100 ms (default)
		011:	200 ms
		100:	500 ms
		101:	1000 ms
		110:	2000 ms
		111:	2000 ms

When the measurement repeat rate is programmed to be faster than possible for the specified ADC measurement time, the repeat rate will be lower than programmed (maximum speed).

Writing to this register stops the ongoing measurements and starts new measurements (depends on the respective bit).

## **ALS\_GAIN and UVS\_Gain**

Default Value: 01HEX

7	6	5	4	3	2	1	0	
0	0	0	0	0		Gain Range		0X0

Field	Bit	Description
LS Gain Range (ALS Mode)	2:0	000: Gain 1
		001: Gain 3 (default)
		010: Gain 6
		011: Gain 9
		100: Gain 18
LS Gain Range (UVS Mode)	2.0	000: Gain 1
		001: Gain 3 (default)
		010: Gain 6
		011: Gain 9
		100: Gain 18

Writing to this register stops the ongoing measurements and starts new measurements (depends on the respective bit).

## PART\_ID

Default Value: B1HEX

7	6	5	4	3	2	1	0	
	Par	t ID			Revisi	ion ID		0X06

Field	Bit	Description	
Part Number ID	7:4	Part number ID	
Revision ID	3:0	Revision ID of the component.	

#### MAIN\_STATUS

Default Value: 20HEX

7	6	5	4	3	2	1	0	
0	0	Power On Status	LS Interrupt Status	LS Data Status	0	0	0	0X07

Field	Bit	Description
Power On status	5	1 = Part went through a power-up event, either because the part was turned on or because there was power supply disturbance. All interrupt threshold settings in the registers have been reset to power-on default states and should be examined if necessary. The flag is cleared after the register is read.
LS Interrupt status	4	0: Interrupt condition not fulfilled (default) 1: Interrupt condition fulfilled (cleared after read)
LS Data status	3	0: old data, already read (default) 1: new data, not yet read (cleared after read)

#### **ALS\_DATA**

Default Value: 00HEX, 00HEX, 00HEX

7	6	5	4	3	2	1	0	
			ALS_Dat	ta_0 [7:0]				0X0D
			ALS_Data	a_1 [15:8]				0x0E
0	0 0 0 0 ALS_Data_2 [19:16]						0X0F	

ALS channel digital output data (unsigned integer, 13 to 20 bit, LSB aligned).

The ALS channel output is already temperature compensated internally: ALS\_DATA = (ALSint – COMP).

When an  $I^2C^{\text{TM}}$  read operation is active and points to an address in the range 07HEX to 18HEX, all registers in this range are locked until the  $I^2C^{\text{TM}}$  read operation is completed or this address range is left.

This guarantees that the data in the registers comes from the same measurement even if an additional measurement cycle ends during the read operation. New measurement data is stored into temporary registers and the actual ALS\_DATA registers are updated as soon as there is no on-going  $I^2C^{\text{TM}}$  read operation to the address range 07HEX to 18HEX.

Reg 0DHEX	Bit[7:0]	ALS diode data least significant data byte
Reg 0EHEX	Bit[7:0]	ALS diode data intervening data byte
Reg 0FHEX	Bit[3:0]	ALS diode data most significant data byte

#### **UVS DATA**

Default Value: 00HEX, 00HEX, 00HEX

7	6	5	4	3	2	1	0	
	UVS_Data_0 [7:0]							
			UVS_Dat	a_1 [15:8]				0x11
0	0 0 0 UVS_Data_2 [19:16]							0X12

UVS channel digital output data (unsigned integer, 13 to 20 bit, LSB aligned).

The UVS channel output is already temperature compensated internally: UVS DATA = (UVint – UVS COMP)

When an  $I^2C^{\text{TM}}$  read operation is active and points to an address in the range 07HEX to 18HEX, all registers in this range are locked until the  $I^2C^{\text{TM}}$  read operation is completed or this address range is left.

This guarantees that the data in the registers comes from the same measurement even if an additional measurement cycle ends during the read operation. New measurement data is stored into temporary registers and the actual UVS\_DATA registers are updated as soon as there is no on-going  $I^2C^{TM}$  read operation to the address range 07HEX to 18HEX.

Reg 10HEX	Bit[7:0]	UVS diode data least significant data byte
Reg 11HEX	Bit[7:0]	UVS diode data intervening data byte
Reg 12HEX	Bit[3:0]	UVS diode data most significant data byte

#### **UVS COMP DATA**

Default Value: 00HEX, 00HEX, 00HEX

7	6	5	4	3	2	1	0	
	UVS_Comp_Data_0 [7:0]							
			UVS_Comp_	Data_1 [15:8]				0x14
0	0 0 0 UVS_Comp Data_2 [19:16]							0X15

UVS Compensation Channel digital output data (unsigned integer, 13 to 20 bit, LSB aligned). The UVS Comp Channel data is clipped at (2Resolution – 1).

When an  $I^2C^{\mathsf{TM}}$  read operation is active and points to an address in the range 07HEX to 18HEX, all registers in this range are locked until the  $I^2C^{\mathsf{TM}}$  read operation is completed or this address range is left.

This guarantees that the data in the registers comes from the same measurement even if an additional measurement cycle ends during the read operation. New measurement data is stored into temporary registers and the actual UVS\_COMP\_DATA registers are updated as soon as there is no on-going  $I^2C^{TM}$  read operation to the address range 07HEX to 18HEX.

Reg 13HEX	Bit[7:0]	UVS Comp diode data least significant data byte
Reg 14HEX	Bit[7:0]	UVS Comp diode data intervening data byte
Reg 15HEX	Bit[3:0]	UVS Comp diode data most significant data byte

#### COMP\_DATA

Default Value: 00HEX, 00HEX, 00HEX

7	6	5	4	3	2	1	0	
	Comp_Data_0 [7:0] 03							0X16
			Comp_Da	ta_1 [15:8]				0x17
0	0	0	0		Comp_Dat	a_2 [19:16]		0X18

ALS compensation channel digital output data (unsigned integer, 13 to 20 bit, LSB aligned). The compensation channel data is clipped at (2Resolution – 1).

If an  $I^2C$  read operation is active and points to an address in the range 07HEX to 18HEX, all registers in this range are locked until the  $I^2C$  read operation is completed or this address range is left.

This guarantees that the data in the registers comes from the same measurement even if an additional measurement cycle ends during the read operation. New measurement data is stored into temporary registers and the actual COMP\_DATA registers are updated as soon as there is no on-going  $I^2C$  read operation to the address range 07HEX to 18HEX.

Reg 16HEX	Bit[7:0]	ALS Comp diode data least significant data byte
Reg 17HEX	Bit[7:0]	ALS Comp diode data intervening data byte
Reg 18HEX	Bit[3:0]	ALS Comp diode data most significant data byte

### **INT\_CFG**

Default Value: 10HEX

7	6	5	4	3	2	1	0	
0	0	LS Interru	LS Interrupt Source		LS Interrupt Enable	0	0	0X19
0	0	LS_IN	LS_INT_SEL		LS_INT_EN	0	0	

FIELD	BIT	DESCRIPTION
LS_INT_SEL	5:4	00: IR Channel
		01: ALS Channel (default)
		10: Reserved
		11: UVS Channel
LS_VAR_MODE	3	0: LS Threshold Interrupt Mode (default)
		1: LS Variation Interrupt Mode
LS_INT_EN	2	0: LS Interrupt Disabled (default)
		1: LS Interrupt Enabled

## INT\_PERSISTENCE

Default Value: 00HEX

7	6	5	4	3	2	1	0	
	LS PE	RSIST		0	0	0	0	0X1A

FIELD	BIT	DESCRIPTION
LS_PERSIST		0000: Every LS value out of threshold range (default) asserts an interrupt.
		0001: 2 consecutive LS values out of threshold range assert an interrupt.
		1111: 16 consecutive LS values out of threshold range assert an interrupt.

### LS\_THRES\_UP

Default Value: FFHEX, FFHEX, 0FHEX

7	6	5	4	3	2	1	0	
			LS_THRI	ES_UP_0				0X21
			LS_THRI	ES_UP_1				0x22
0	0	0	0		LS_THRI	ES_UP_2		0X23

LS\_THRES\_UP\_x sets the upper threshold value for the LS interrupt. The Interrupt Controller compares the value in LS\_THRES\_UP\_x against measured data in the DATA\_x registers of the selected LS interrupt channel. It generates an interrupt event if DATA\_x exceeds the threshold level.

The data format for LS\_THRES\_UP\_x must match that of the DATA\_x registers.

Reg 21HEX	Bit[7:0]	LS upper interrupt threshold value, LSB
Reg 22HEX	Bit[7:0]	LS upper interrupt threshold value, intervening byte
Reg 23HEX	Bit[3:0]	LS upper interrupt threshold value, MSB

### LS\_THRES\_LOW

Default Value: 00HEX, 00HEX, 00HEX

7	6	5	4	3	2	1	0	
	LS_THRES_LOW_0							0X24
			LS_THRE	S_LOW_1				0x25
0	0 0 0 0 LS_THRES_LOW_2						0X26	

LS\_THRES\_LOW\_x sets the lower threshold value for the LS interrupt. The Interrupt Controller compares the value in LS\_THRES\_LOW\_x against measured data in the DATA\_x registers of the selected LS interrupt channel. It generates an interrupt event if the DATA\_x is below the threshold level.

The data format for LS\_THRES\_LOW\_x must match that of the DATA\_x registers.

Reg 24HEX	Bit[7:0]	LS lower interrupt threshold value, LSB
Reg 25HEX	Bit[7:0]	LS lower interrupt threshold value, intervening byte
Reg 26HEX	Bit[3:0]	LS lower interrupt threshold value, MSB

### LS\_THRES\_VAR

Default Value: 00HEX

7	6	5	4	3	2	1	0	
0	0	0	0	0		LS_THRES_VAR	}	0X27

FIELD	BIT	DESCRIPTION
LS_THRES_VAR	2:0	000: new LS_DATA varies by 8 counts compared to previous result.
		001: new LS_DATA varies by 16 counts compared to previous result.
		010: new LS_DATA varies by 32 counts compared to previous result.
		011: new LS_DATA varies by 64 counts compared to previous result.
		1111: new LS_DATA varies by 1024 counts compared to previous result.

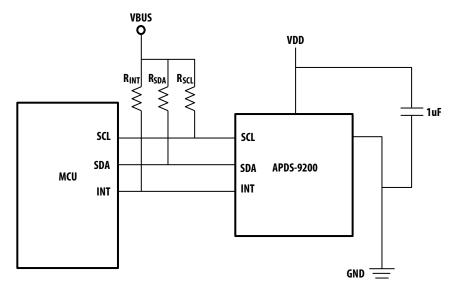
### **Application Information Hardware**

The application hardware circuit for using implementing UVS and ALS is simple with the APDS-9200 and is shown in following figure. The bypass capacitor is placed as close to the device package and is connected directly to the power source and to the ground, as shown in the following figure. It allows the AC component of the V<sub>DD</sub> to pass through to ground. It is suggested to have bypass capacitor that have low effective series resistance (ESR) and low effective series inductance (ESI), such as the common ceramic types, which provide a low impedance path to ground at high frequencies to handle transient currents caused by internal logic switching.

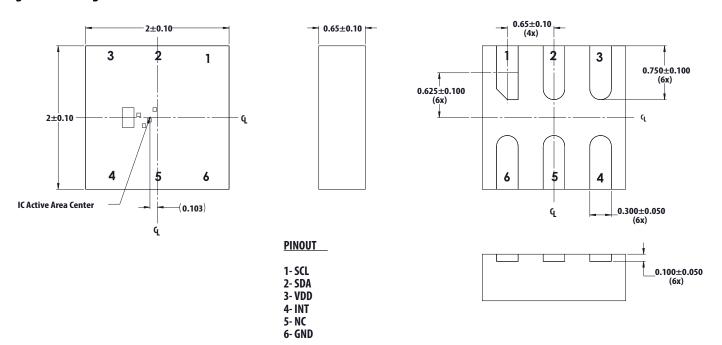
Pull-up resistors, RSDA and RSCL, maintain the SDA and SCL lines at a high level when the bus is free and ensure the signals are pulled up from a low to a high level within the required rise time. A pull-up resistor,  $R_{INT}$ , is also required for the interrupt (INT), which functions as a wired-AND signal in a similar fashion to the SCL and SDA lines. A typical impedance value of 10 k $\Omega$  can be used.

For a complete description of I<sup>2</sup>C maximum and minimum R1 and R2 values, please review the I<sup>2</sup>C Specification at http://www.semiconductors.philips.com.

Figure 19 Application Hardware Circuit

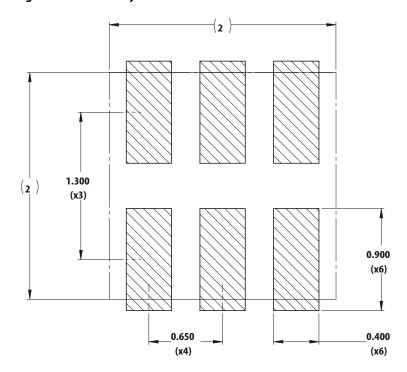


**Figure 20 Package Outline Dimensions** 



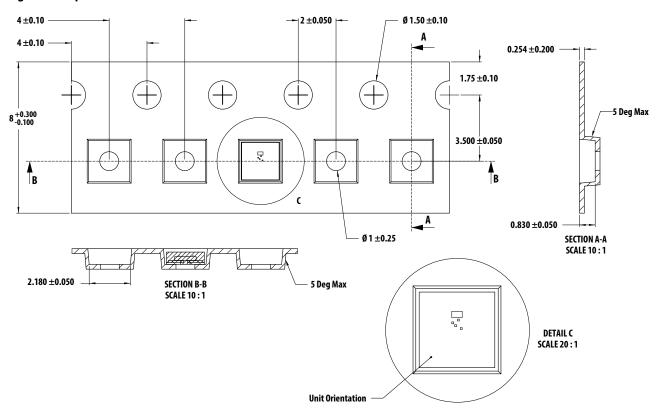
**NOTE** All dimensions are in millimeters.

Figure 21 PCB Pad Layout



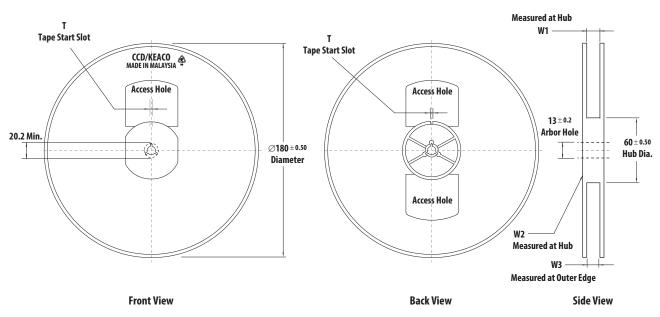
**NOTE** All dimensions are in millimeters.

**Figure 22 Tape Dimensions** 



**NOTE** All dimensions are in millimeters.

**Figure 23 Reel Dimensions** 

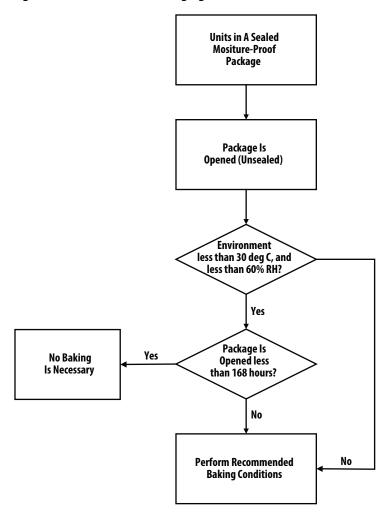


**NOTE** All dimensions are in millimeters.

## **Moisture Proof Packaging**

All APDS-9200 options are shipped in moisture proof package. Once opened, moisture absorption begins. This part is compliant to JEDEC MSL 3.

**Figure 24 Moisture Proof Packaging** 



**Table 8 Baking Conditions** 

Package	Temperature	Time	
In Reel	60°C	48 hours	
In Bulk	100°C	4 hours	

If the parts are not stored in dry conditions, they must be baked before reflow to prevent damage to the parts.

Baking should only be done once.

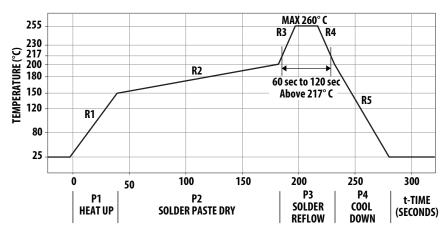
**Table 9 Recommended Storage Conditions** 

Storage Temperature	10°C to 30°C
Relative Humidity	below 60% RH

#### Time from unsealing to soldering:

After removal from the bag, the parts should be soldered within 168 hours if stored at the recommended storage conditions. If times longer than 168 hours are needed, the parts must be stored in a dry box.

Figure 25 Recommended Reflow Profile



**Table 10 Reflow Information** 

Process Zone	Symbol	ΔΤ	Maximum ∆T/∆time or Duration
Heat Up	P1, R1	25°C to 150°C	3°C/s
Solder Paste Dry	P2, R2	150°C to 200°C	100 s to 180s
Solder Reflow	P3, R3	200°C to 260°C	3°C/s
	P3, R4	260°C to 200°C	−6°C/s
Cool Down	P4, R5	200°C to 25°C	−6 °C/s
Time maintained above liquidus point, 217°C		> 217°C	60s to 120s
Peak Temperature		260°C	_
Time within 5°C of actual Peak Temperature		> 255°C	20s to 40s
Time 25°C to Peak Temperature		25°C to 260°C	8 mins

The reflow profile is a straight-line representation of a nominal temperature profile for a convective reflow solder process. The temperature profile is divided into four process zones, each with different  $\Delta T/\Delta time$  temperature change rates or duration. The  $\Delta T/\Delta time$  rates or duration are detailed in the above table. The temperatures are measured at the component to printed circuit board connections.

In process zone P1, the PC board and component pins are heated to a temperature of 150°C to activate the flux in the solder paste. The temperature ramp up rate, R1, is limited to 3°C per second to allow for even heating of both the PC board and component pins.

Process zone P2 should be of sufficient time duration (100 to 180 seconds) to dry the solder paste. The temperature is raised to a level just below the liquidus point of the solder.

Process zone P3 is the solder reflow zone. In zone P3, the temperature is quickly raised above the liquidus point of solder to 260°C (500°F) for optimum results. The dwell time above the liquidus point of solder should be between 60 and 120 seconds. This is to assure proper coalescing of the solder paste into liquid solder and the formation of good solder

connections. Beyond the recommended dwell time the intermetallic growth within the solder connections becomes excessive, resulting in the formation of weak and unreliable connections. The temperature is then rapidly reduced to a point below the solidus temperature of the solder to allow the solder within the connections to freeze solid.

Process zone P4 is the cool down after solder freeze. The cool down rate, R5, from the liquidus point of the solder to 25°C (77°F) should not exceed 6°C per second maximum. This limitation is necessary to allow the PC board and component pins to change dimensions evenly, putting minimal stresses on the component.

It is recommended to perform reflow soldering no more than twice.

It is recommended to perform a calibration of the UVS ADC output against a calibrated UV test light source after final reflow and product assembly.

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